

## N & P Channel 60-V Dual MOSFETs

### **Description**

These N+P dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

#### **Features**

- · Fast switching
- · Green Device Available
- Suit for 4.5V Gate Drive Applications

#### **Applications**

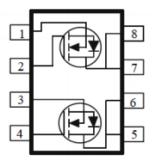
- · DC Fan
- · Motor Drive Applications
- Networking
- · Half / Full Bridge Topology

#### **Packing & Order Information**

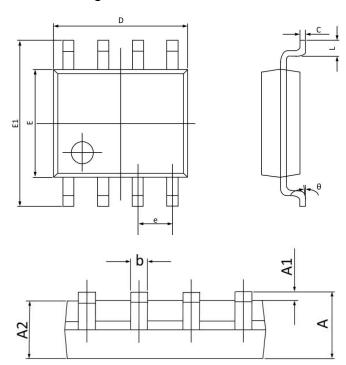
3,000/Reel



#### **Graphic symbol**



### SO-8 Package information



Symbol	Dimensions I	n Millimeters	Dimension	s In Inches
Symbol	MAX	MIN	MAX	MIN
A	1.750	1.350	0.069	0.053
A1	0.250	0.100	0.010	0.004
A2	1.500	1.300	0.059	0.051
b	0.490	0.350	0.019	0.014
C	0.260	0.190	0.010	0.007
D	5.100	4.700	0.201	0.185
E	4.100	3.700	0.161	0.146
E1	6.200	5.800	0.244	0.228
e	1.27BSC		0.05	BSC
L	0.900	0.400	0.035	0.016
θ	8°	0°	8°	0°



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# MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (T <sub>A</sub> =25°C unless otherwise specified)								
Symbol	Parameter	Ra	Rating					
$V_{DS}$	Drain-Source Voltage	60	-60	V				
V <sub>GS</sub>	Gate-Source Voltage	±20	±20	V				
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> =25°C)	4.5	-3.5	А				
<b>I</b> D	Drain Current - Continuous (T <sub>C</sub> =70°C)	2.85	-2.21	А				
I <sub>DM</sub>	Drain Current - Pulsed <sup>1</sup>	18	-14	А				
D	Power Dissipation (T <sub>C</sub> =25°C)	3	.57	W				
$P_{D}$	Power Dissipation - Derate above 25°C	0.	028	W/°C				
TJ	Storage Temperature Range	-55 t	-55 to 150					
T <sub>STG</sub>	Operating Junction Temperature Range	-55 t	o 150	°C				

Thermal Resistance Ratings								
Symbol	Parameter	Тур.	Max.	Units				
$R_{\thetaJA}$	Thermal Resistance Junction to ambient		75	°C/W				
$R_{ heta JC}$	Thermal Resistance Junction to Case		35	C/VV				

## N-CH Electrical Characteristics (TJ=25 °C, unless otherwise)

Off Charac	Off Characteristics									
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units				
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = V_{GS}$ , $I_D = 250uA$	60			V				
ΔBV <sub>DSS</sub> /ΔTJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> = 1mA		0.05		V/°C				
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS} = 0 \text{ V}$ , $V_{GS} = \pm 20 \text{ V}$			±100	nA				
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> = 60 V , V <sub>GS</sub> = 0 V , TJ=25°C V <sub>DS</sub> = 48 V , V <sub>GS</sub> = 0 V , TJ=125°C			1 10	uA				

On Characteristics									
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units			
R <sub>DS(on)</sub>	Static Drain-Source	$V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$		45	54	0			
	On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 3 \text{ A}$		52	63	mΩ			
$V_{GS(th)}$	Gate Threshold Voltage	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	1.2	1.8	2.5	V			
$\Delta V_{GS(th)}$	Temperature Coefficient	$V_{GS} = V_{DS}$ , $I_D = 250uA$		-4.2		mV/°C			
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4 A		4.2		S			



# N & P Channel 60-V Dual MOSFETs

Dynamic	Dynamic and switching Characteristics										
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units					
$Q_g$	Total Gate Charge <sup>2,3</sup>			14	21	nC					
$Q_{gs}$	Gate-Source Charge <sup>2,3</sup>	$V_{DS} = 30 \text{ V}, I_{D} = 4 \text{ A},$ $V_{GS} = 10 \text{ V}$		2.9	5	nC					
$Q_{gd}$	Gate-Drain Charge <sup>2,3</sup>	V <sub>GS</sub> = 10 V		2.3	4	nC					
t <sub>d(on)</sub>	Turn-On Delay Time <sup>2,3</sup>	$I_{D} = 1 \text{ A}$ , $R_{G} = 3.3 \Omega$ ,		3.9	7	ns					
t <sub>r</sub>	Rise Time <sup>2,3</sup>			12.6	24	ns					
t <sub>d(off)</sub>	Turn-Off Delay Time <sup>2,3</sup>	$V_{GS} = 10 \text{ V}, V_{DD} = 30 \text{ V}$		23.1	44	ns					
tf	Fall Time <sup>2,3</sup>			6.7	13	ns					
C <sub>ISS</sub>	Input Capacitance			800	1160	pF					
Coss	Output Capacitance	$V_{DS} = 15 \text{ V}$ f = 1 MHz , $V_{GS} = 0 \text{ V}$		380	550	pF					
C <sub>RSS</sub>	Reverse Transfer Capacitance			115	170	pF					
Rg	Total Gate Charge	$V_{DS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ , $V_{GS} = 0 \text{ V}$		1.7	3.4	Ω					

Drain-Sοι	Drain-Source Diode Characteristics and Maximum Ratings									
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units				
Is	Continuous Source Current	$V_G = V_D = 0 V$ , Force Current			4.5	Α				
I <sub>SM</sub>	Pulsed Source Current				9	Α				
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> = 0 V , I <sub>S</sub> = 1 A , TJ = 25°C			1	V				

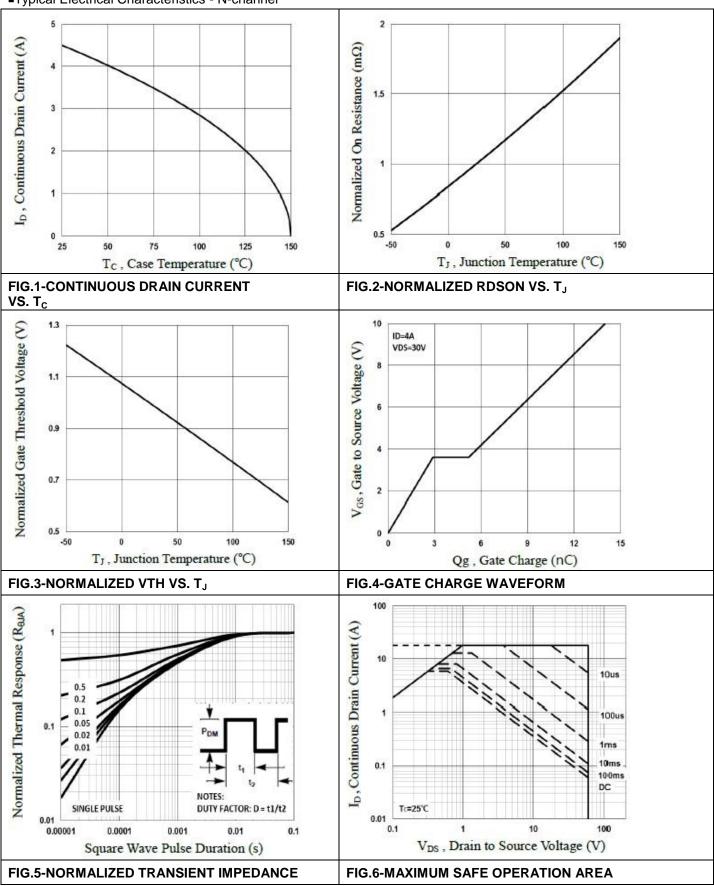
#### Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq 300 \text{us}$  , duty cycle  $\leq 2\%$ .
- 3. Essentially independent of operating temperature.



### N & P Channel 60-V Dual MOSFETs

■Typical Electrical Characteristics - N-channel





### N & P Channel 60-V Dual MOSFETs

P-CH Electrical Characteristics (TJ=25 °C, unless otherwise)

Off Charac	Off Characteristics									
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units				
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = V_{GS}$ , $I_D = 250uA$	-60			V				
ΔBV <sub>DSS</sub> /ΔTJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> = 1mA		-0.05		V/°C				
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS} = 0 \text{ V}$ , $V_{GS} = \pm 20 \text{ V}$			±100	nA				
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS} = -60 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $TJ=25^{\circ}\text{C}$ $V_{DS} = -48 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $TJ=125^{\circ}\text{C}$			-1 10	uA				

On Characteristics								
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units		
R <sub>DS(on)</sub> Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -6 \text{ A}$		87	105	mΩ			
	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -3 \text{ A}$		120	145	11122		
$V_{\text{GS(th)}}$	Gate Threshold Voltage	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	-1.0	-1.6	-2.5	V		
$\Delta V_{GS(th)}$	Temperature Coefficient	$V_{GS} = V_{DS}$ , $I_D = 250uA$		3		mV/°C		
<b>g</b> fs	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_{D} = -6 \text{ A}$		5.5		S		

Dynamic	Dynamic and switching Characteristics										
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units					
$Q_g$	Total Gate Charge <sup>2,3</sup>			10	15	nC					
$Q_{gs}$	Gate-Source Charge <sup>2,3</sup>	$V_{DS} = -30 \text{ V}, I_{D} = -4 \text{ A},$ $V_{GS} = -10 \text{ V}$		1.6	3.2	nC					
$Q_{gd}$	Gate-Drain Charge <sup>2,3</sup>			3	6	nC					
t <sub>d(on)</sub>	Turn-On Delay Time <sup>2,3</sup>			8	16	ns					
t <sub>r</sub>	Rise Time <sup>2,3</sup>	$I_D = 1 \text{ A}$ , $R_G = 6 \Omega$ ,		15.4	30	ns					
t <sub>d(off)</sub>	Turn-Off Delay Time <sup>2,3</sup>	$V_{GS} = -30 \text{ V}$ , $V_{DD} = -30 \text{ V}$		42.5	80	ns					
tf	Fall Time <sup>2,3</sup>			8.4	16	ns					
C <sub>ISS</sub>	Input Capacitance			785	1300	pF					
Coss	Output Capacitance	$V_{DS} = -30 \text{ V}$ f = 1 MHz, $V_{GS} = 0 \text{ V}$		175	300	pF					
C <sub>RSS</sub>	Reverse Transfer Capacitance	T = T IVITIZ, VGS = U V		112	220	pF					

Drain-Sou	Drain-Source Diode Characteristics and Maximum Ratings									
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units				
Is	Continuous Source Current	$V_G = V_D = 0 V$ , Force Current			-3.5	Α				
I <sub>SM</sub>	Pulsed Source Current				-7	Α				
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> = 0 V , I <sub>S</sub> = -1 A , TJ = 25°C			-1	V				

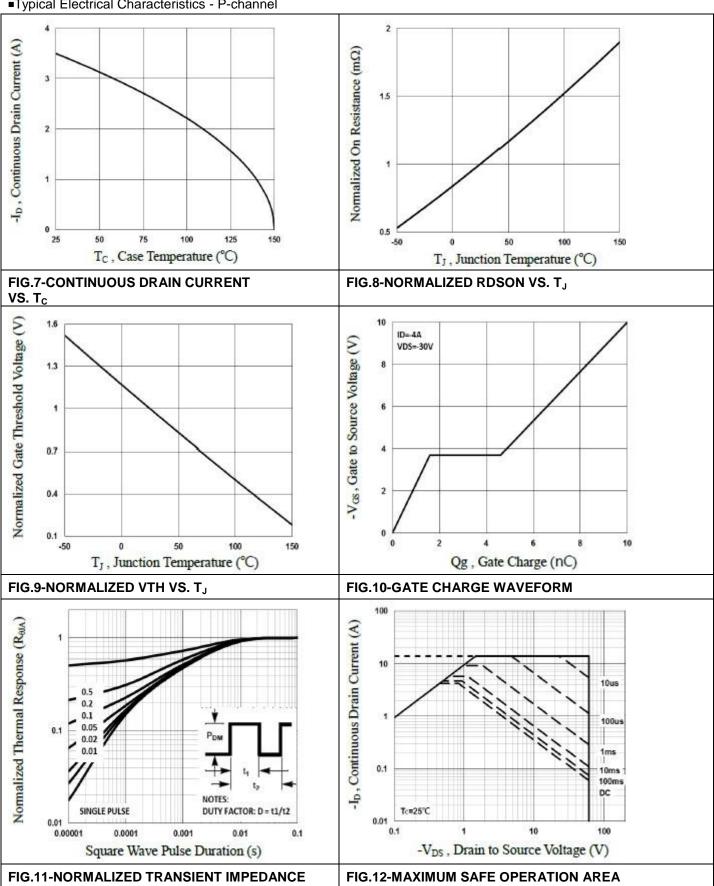
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- 3. Essentially independent of operating temperature.



### N & P Channel 60-V Dual MOSFETs

■Typical Electrical Characteristics - P-channel





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